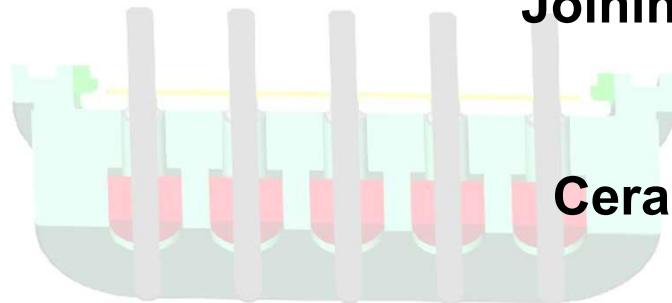
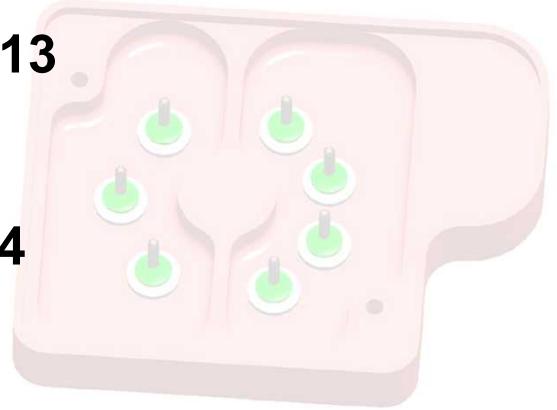


# Effects of Glass-Ceramic Sealing Cycle on Paliney-7 Pin Microstructure and Hardness

(Paliney is a trade name of Deringer-Ney Inc., Bloomfield, CT)



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Joining and Coatings Dept. 1813  
and  
**Ron G. Stone**  
Ceramic and Glass Dept. 2454

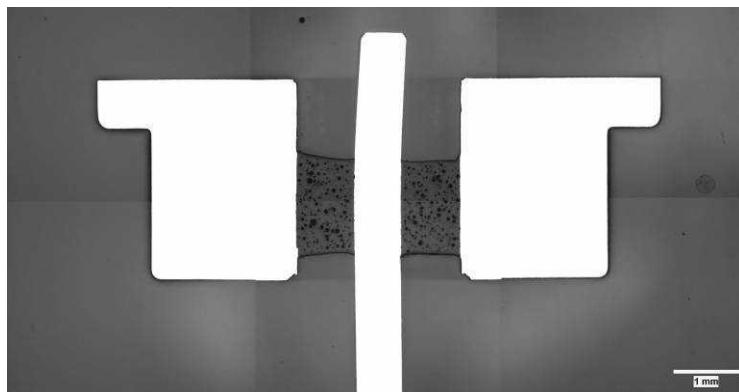


**JOWOG-28 Meeting**  
**May 5<sup>th</sup>, 2008**



# Motivation

- Initial glass-ceramic/metal sealing trials resulted in Paliney-7 pin hardness that was marginal or low. The requirement is >300 HKN (100g Knoop microhardness). The initial seal cycle consisted of slow-cool (6°C/min) from 1000°C to 660°C, followed by faster cooling (25°C/min) to 482°C where the pins are age hardened in-situ.
- In addition, differences among Pal-7 heats were observed with one particular “wire” lot showing significantly lower hardness.



“single-pin” G-C/metal seal  
with Pal-7 pin and 304L shell



# Paliney-7 Precious Metal Contact Alloy

- Pd-based alloy with the following composition (ASTM B540):

Element	Composition, weight %
Palladium	34.0–36.0
Silver	29.0–31.0
Copper	13.5–14.5
Gold	9.5–10.5
Platinum	9.5–10.5
Zinc	0.8–1.2
Total platinum group metal impurities (iridium, osmium, rhodium, ruthenium)	0.1 max
Total base metal impurities	0.2 max

- Melting point (solidus) is 1015°C, so we must be careful with regard to furnace overheating, etc. Our latest process is to lower the G-C/Metal sealing temp. from 1000°C to 975°C.
- The standard age hardening (precipitation hardening) treatment is 482°C for 45 minutes. According to ASTM B540, Knoop hardness in the annealed condition is 200-260HKN (UTS~105-130ksi) and in the hardened condition it is 310-360HKN (UTS~155-185ksi).

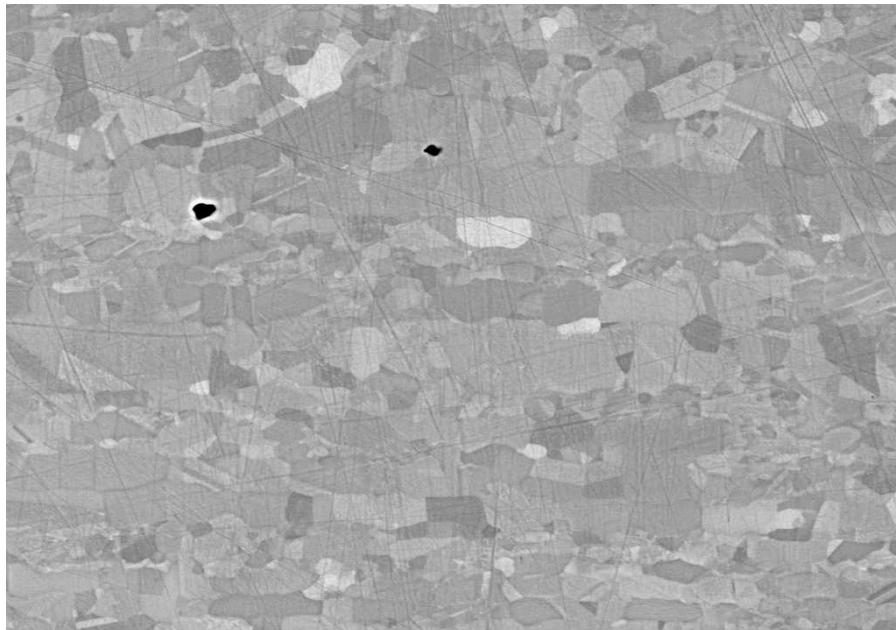
# As-Received (Annealed) Material



10 µm

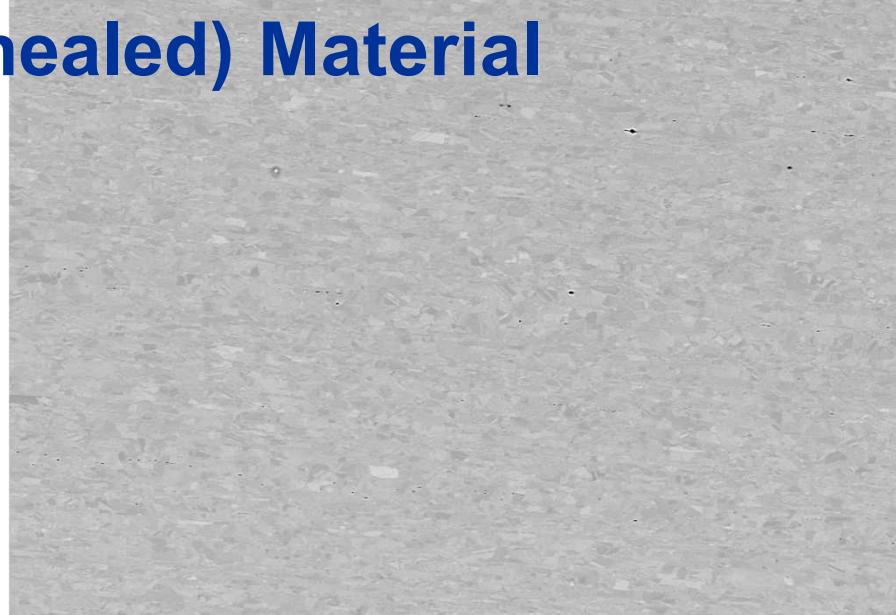
EHT = 20.00 kV WD = 5 mm Signal A = QBSD File Name = As\_received\_rod\_01.tif

As-received Pal 7 "Rod"



2 µm

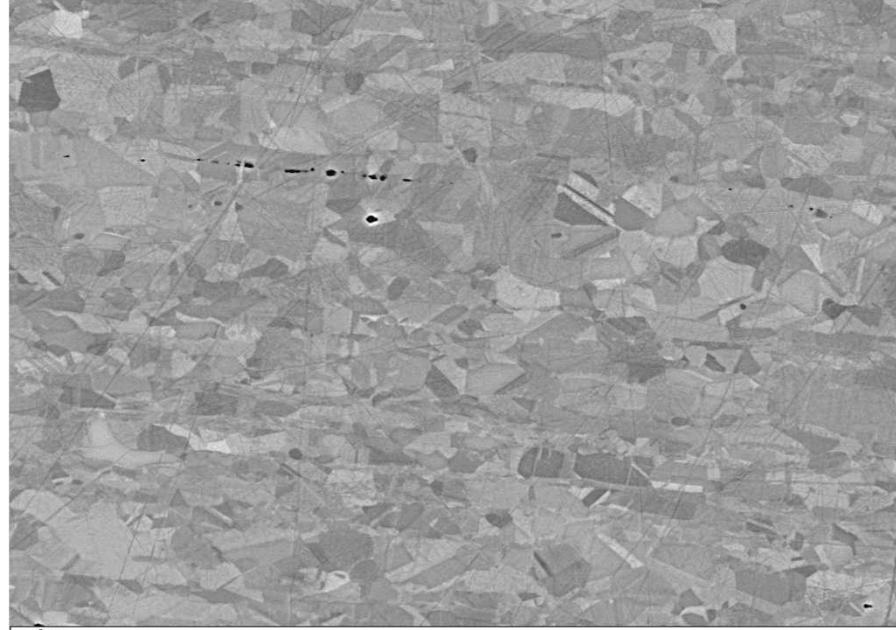
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20 µm

EHT = 20.00 kV WD = 5 mm Signal A = QBSD File Name = As\_received\_wire\_01.tif

As-received Pal 7 "Wire"



2 µm

EHT = 20.00 kV WD = 5 mm Signal A = QBSD File Name = As\_received\_wire\_02.tif



## As-Received (Annealed) Material

- Some differences observed in Knoop hardness of as-received, annealed material:
  - As-received Pal-7 rod: 193 Knoop (UTS=106ksi reported by manufacturer)
  - As-received Pal-7 wire: 226 Knoop (UTS=116ksi reported by manufacturer)
- In the as-received condition, Pal-7 rod has slightly larger grain size than Pal-7 wire (and a more “duplex” grain structure). The wire has slightly smaller grain size and possibly a more deformed grain structure. These differences account for the lower hardness observed in as-received Pal-7 rod compared to wire.



## Two heats of Paliney-7 displayed different hardness responses to BPS glass-ceramic processing: “Rod” heat was marginal, “Wire” heat had low hardness

Results from early G-C/metal seal trials

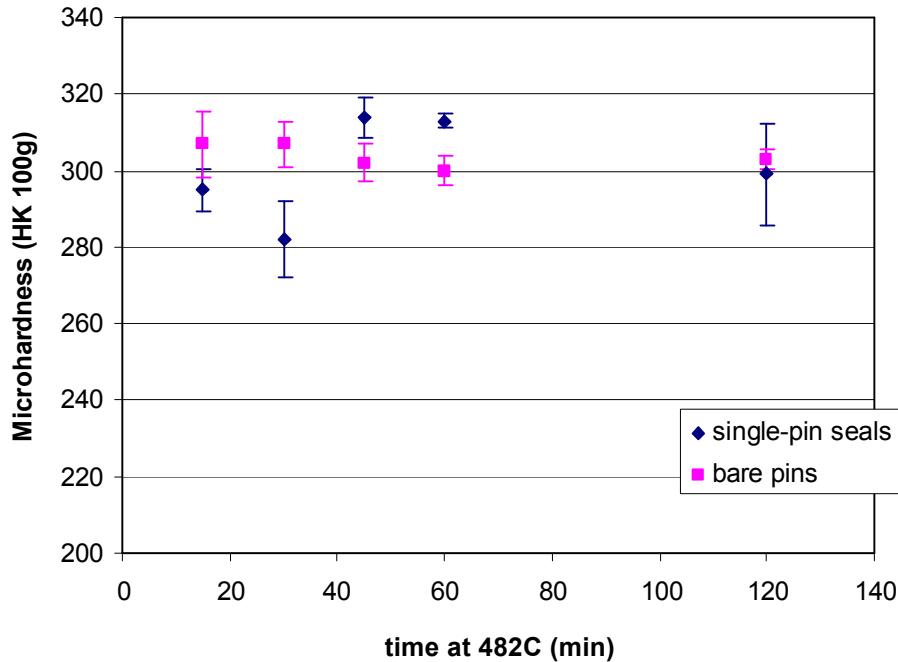
Thermal Profile	Paliney 7 Pin Hardness (Knoop Hardness)
RT to 1000C @ 25C/min; hold 12min; to 660C @ 6C/min; 0min hold; to 482C @ 25C/min with 45 min hold; to RT @ 5 C/min	Rod 293 / 307
RT to 1000C @ 25C/min; hold 12min; to 660C @ 6C/min; 0min hold; to 482C @ 25C/min with 45 min hold; to RT @ 5 C/min	Rod 298 / 302
RT to 1000C @ 25C/min; hold 12min; to 660C @ 6C/min; 0min hold; to 482C @ 25C/min with 45 min hold; to RT @ 5 C/min	Wire 259

Chemical analysis results from two heats of Pal-7

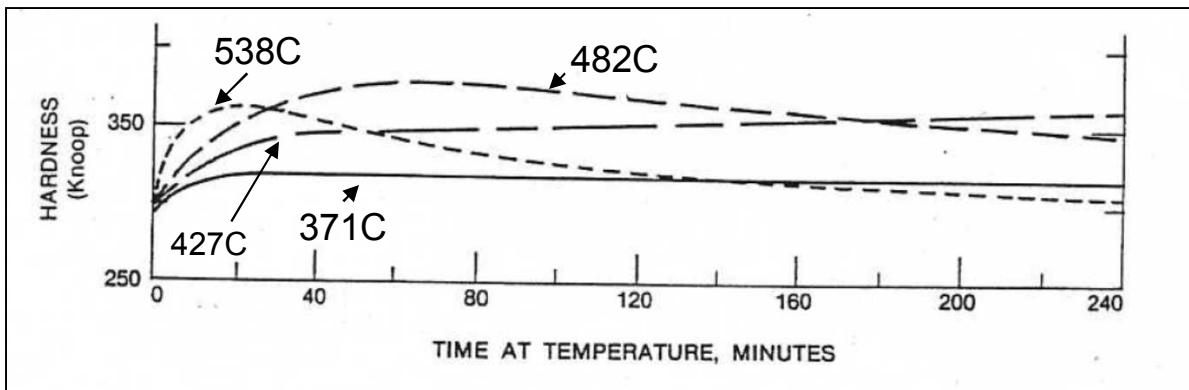
Melt #	Composition (wt.%)							
	Ag	Zn	Pd	Cu	Ni	Au	Fe	Pt
W34680W (wire)	30.39	0.97	34.82	14.09	0.02	10.00	0.01	9.84
W43004W (rod)	30.07	0.94	34.86	13.88	<.0014	9.98	<.0024	9.83

- Only slight differences in the bulk chemistry of the heats
- “Rod” vs. “wire”: processed the same except that rod is “batch annealed” (short lengths are heat treated in a batch oven) and wire is “strand annealed” (continuous feedthrough of wire through an oven)
- Glass sealing process at 1000°C should remove any effects of prior processing of the materials
- However, minor differences in chemistry, not shown in the melt cert., could affect the precipitation hardening process and the final hardness after G-C sealing

# 1<sup>st</sup> Attempt to Improve Pin hardness – Aging Time at 482°C – showed no significant effect on final hardness



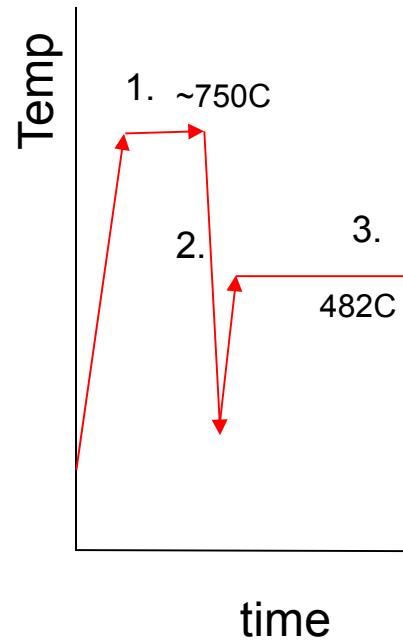
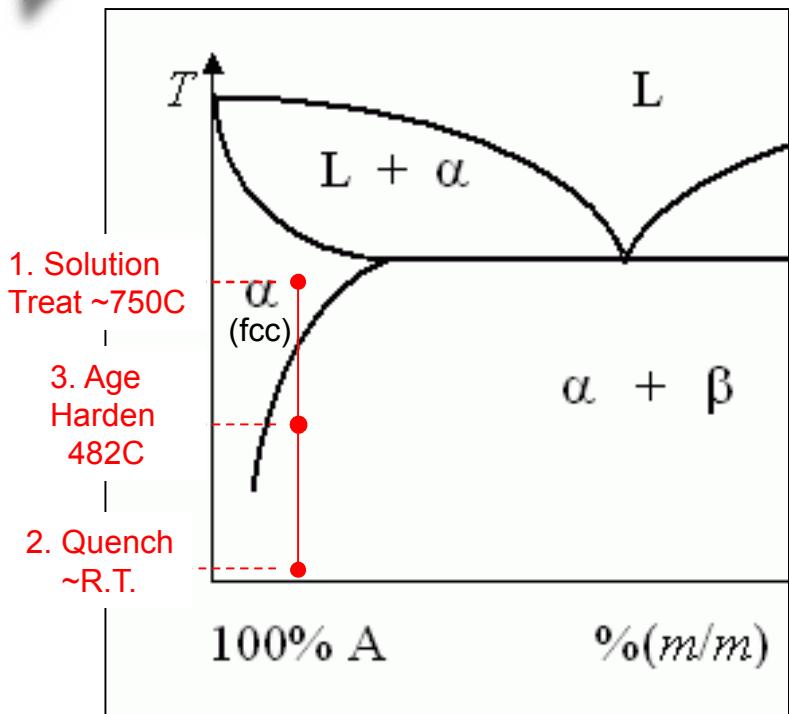
- Varied the hold time at 482°C *after* cooldown from G-C/metal sealing
- Hardness values were low or marginal in all cases (“wire” heat)
- No consistent trend of hardness vs. age hardening time



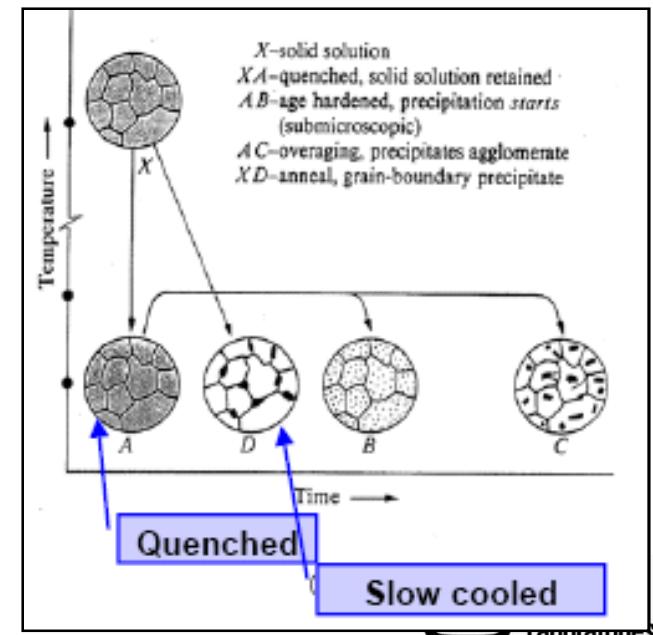
S. Brooks and G. Reed,  
“Age Hardening Ney Alloys”,  
Ney Scope,  
Vol. 22, No. 1,  
Jan. 1980.

# Typical Age-Hardening Process for Paliney-7:

Solution treat  $\sim 750\text{-}850^\circ\text{C}$ , fast quench, age at  $482^\circ\text{C}$



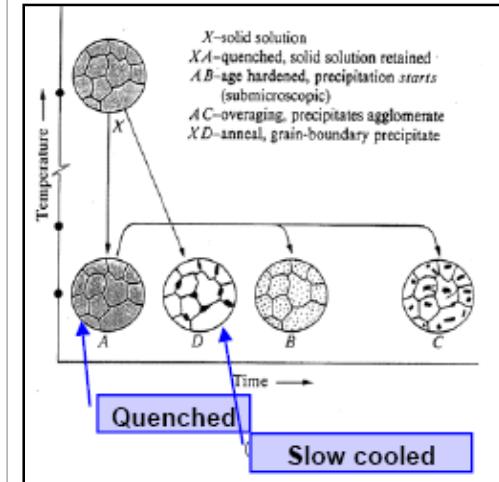
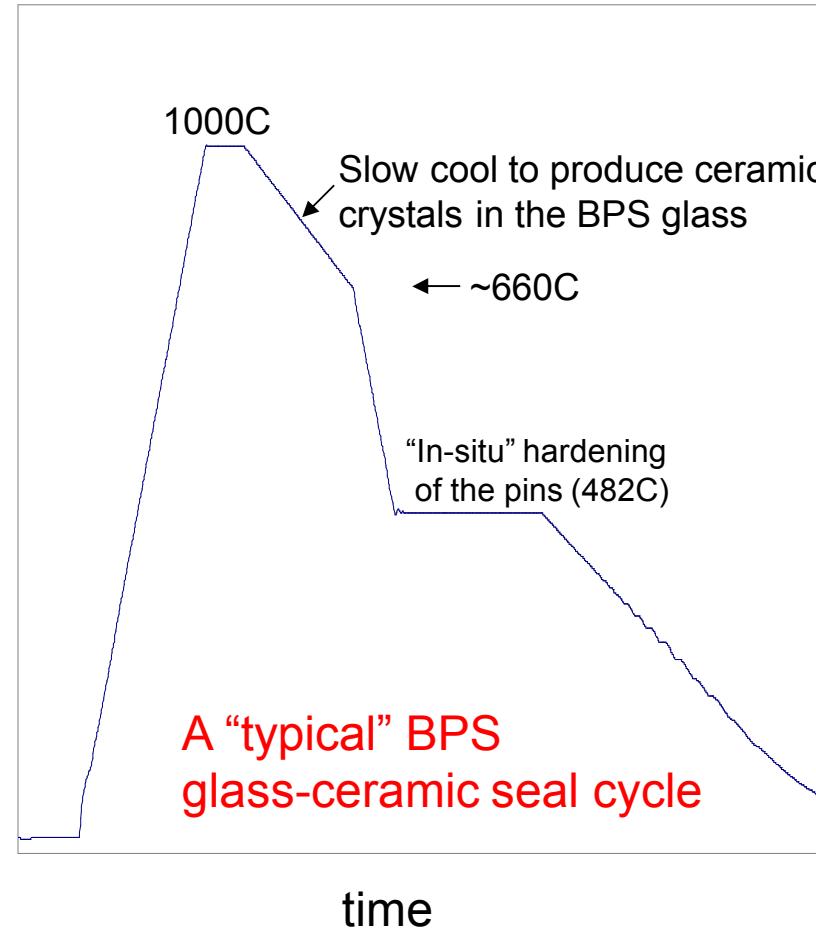
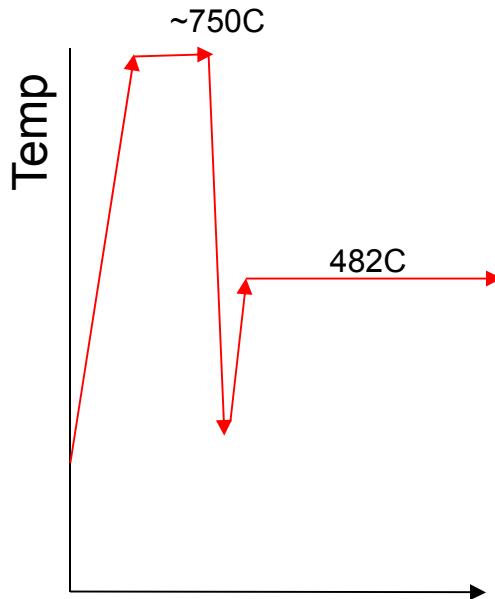
- Typical solution treat temp. is  $750^\circ\text{C}$  or above, according to the vendor Deringer-Ney



- Binary phase diagram is used to illustrate age hardening...Paliney 7 is a much more complex multicomponent alloy
- It appears that the solvus for the age hardening precipitate is below approx.  $700\text{-}725^\circ\text{C}$
- The standard age hardening heat treatment of Paliney-7 is capable of producing 340-380 HKN

# Compare to BPS glass-ceramic sealing cycle: Slow-cooling through the apparent solvus range

Ideal precipitation-hardening process

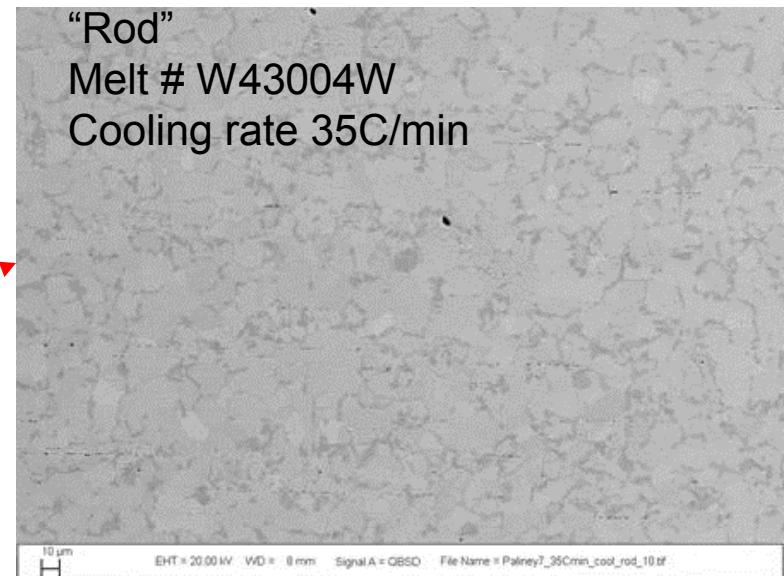
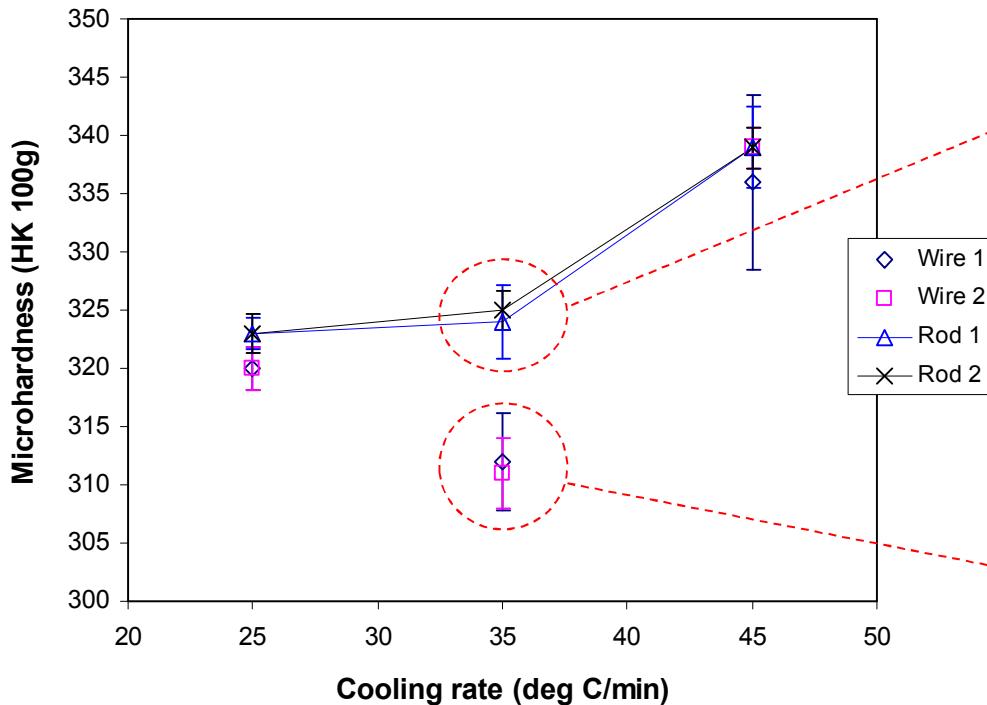


- The slow-cooling rate and long time spent at high temperatures are the likely causes of reduced hardness

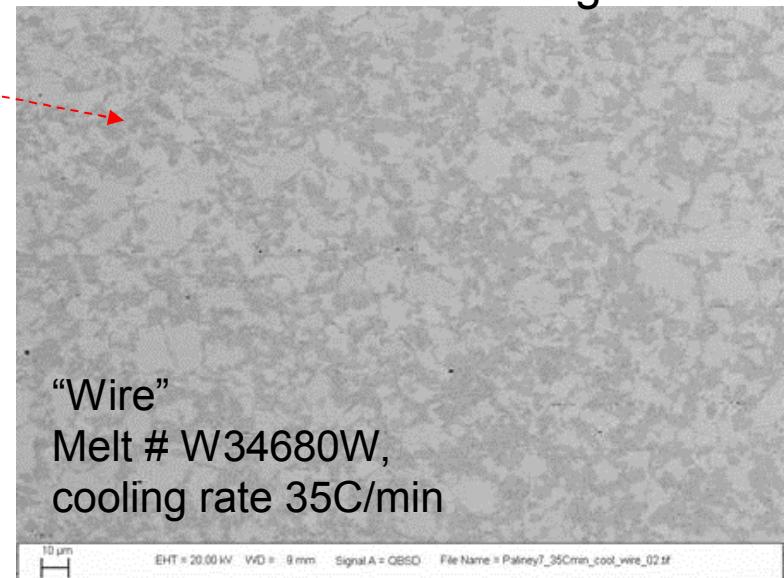
(Original thermal profile was slow-cool to 660C, then faster cool to 482C)

## 2<sup>nd</sup> Attempt: Cooling Rate Study -- Some Hardness and Microstructural Differences Between Rod and Wire Heats

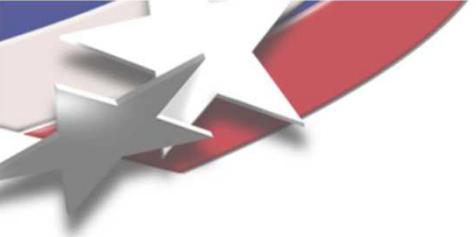
- Paliney-7 pin samples heated to 1000°C and cooled at 25, 35, and 45°C/min



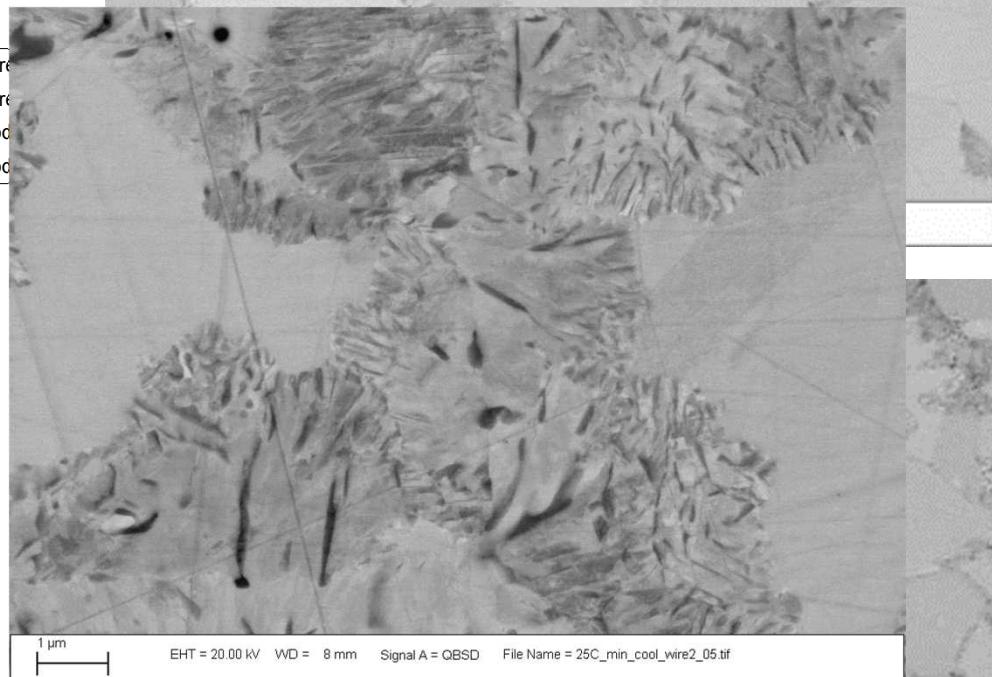
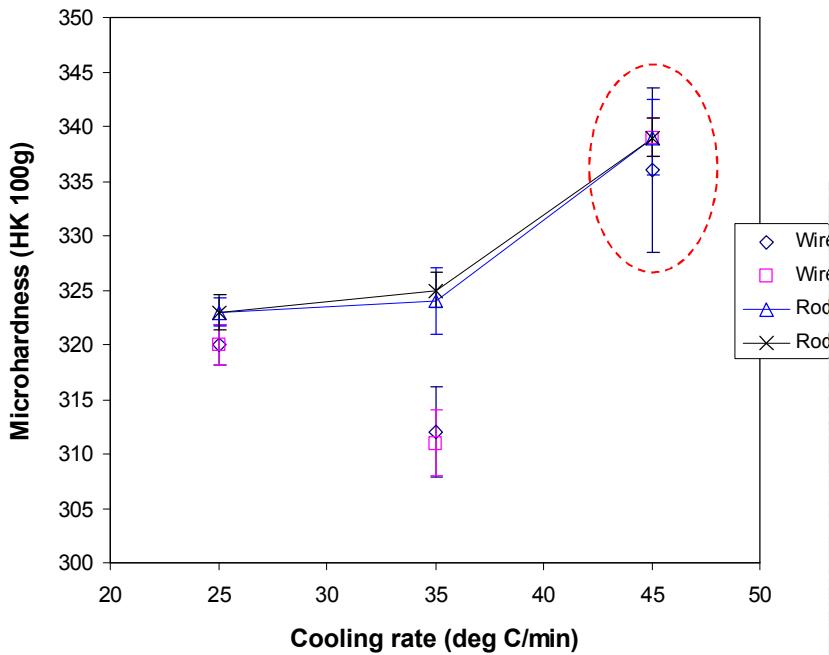
Backscatter SEM images



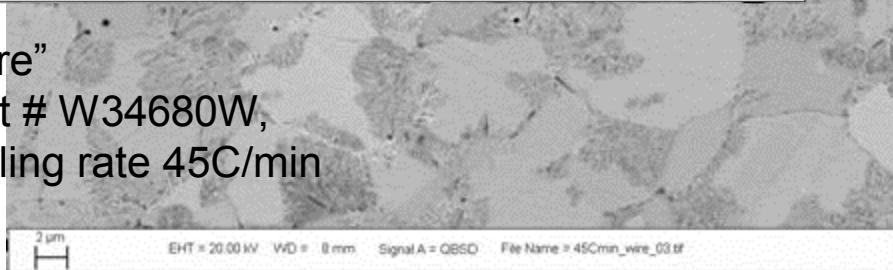
- Some differences observed between rod and wire, although inconsistent with cooling rate.
- Backscatter SEM revealed *multiphase* Pal 7 microstructure.



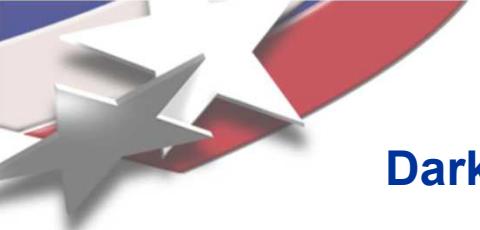
“Rod”  
Melt # W43004W  
Cooling rate 45C/min



“Wire”  
Melt # W34680W,  
cooling rate 45C/min



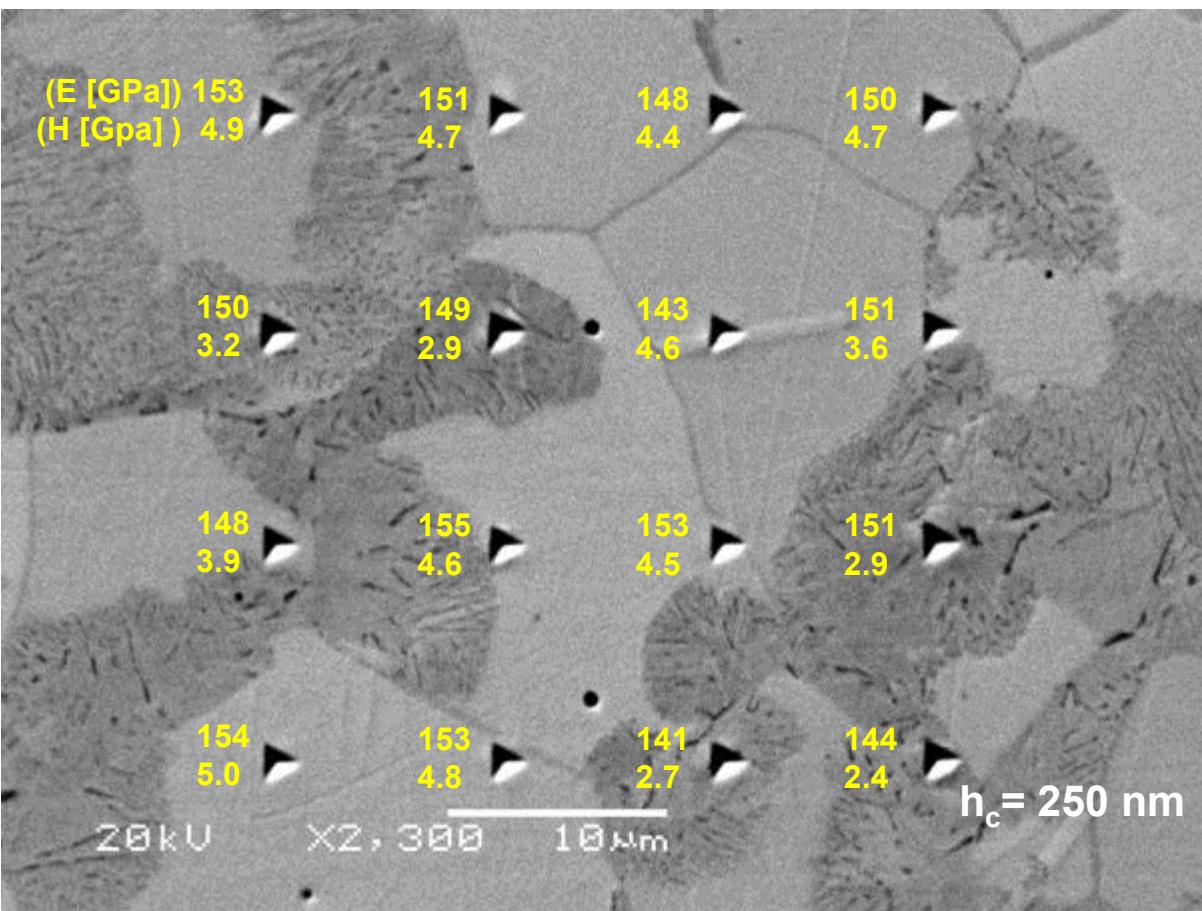
- Multiphase Pal 7 structure found for other cooling rates as well.
- Lower amount of 2-phase regions along grain boundaries in the rod material.
- **This suggested that lower hardness in wire is due to the 2 phase structure produced during G-C/metal seal processing.**



# Nano-Indentation Results:

## Dark 2-phase Regions are Softer than the Matrix Grains

- Indent array covers different microstructural regions of the sample



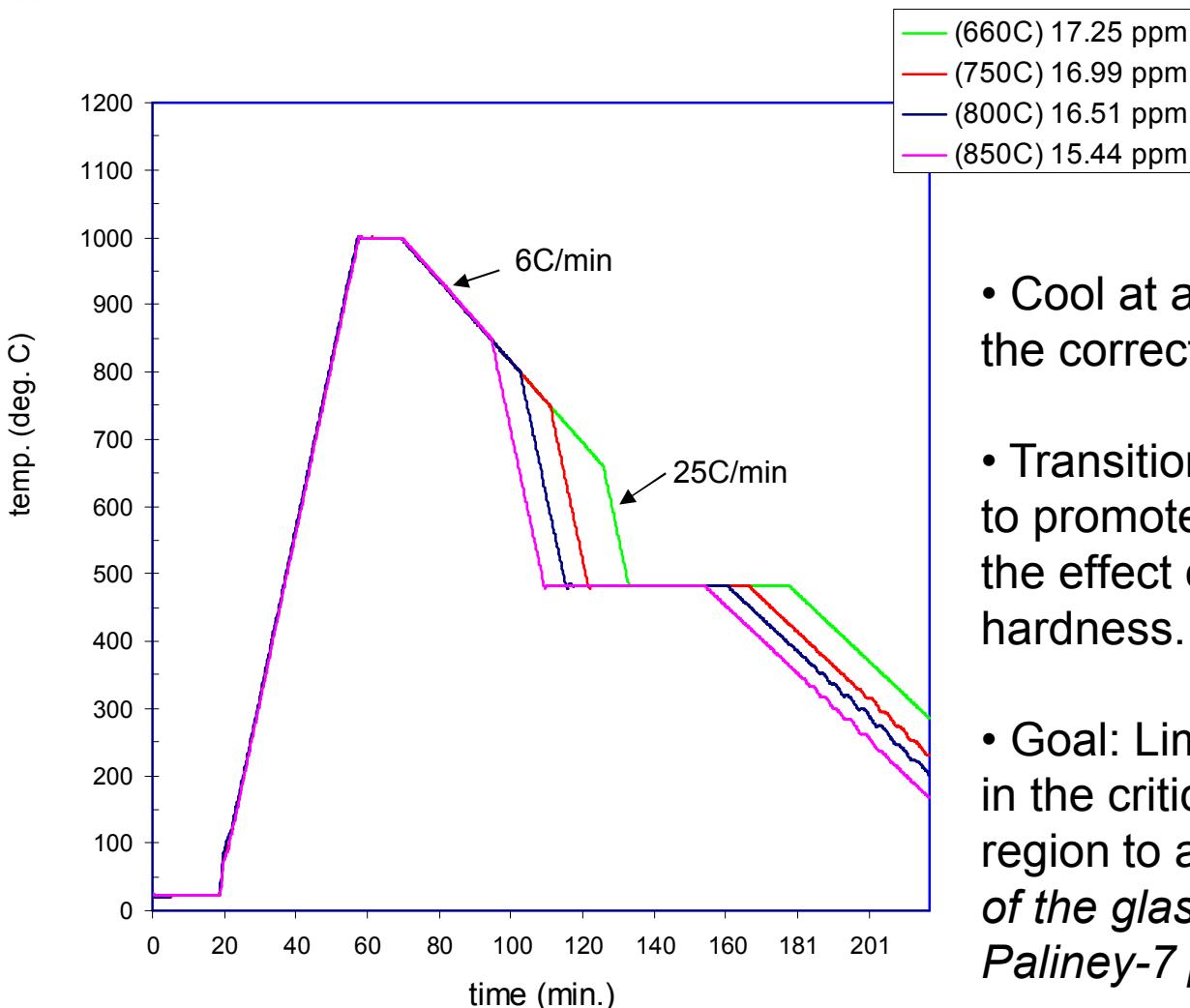
“Wire”  
Melt # W34680W,  
cooling rate  $35^\circ\text{C}/\text{min}$

$E_{\text{avg}} = 150 \pm 4 \text{ GPa}$   
 $E$  (as per ASTM B540)= 117 GPa  
•Discrepancy possibly due to indent  
'pile-up'

$H_{\text{light}} = 4.5 \pm 0.4 \text{ GPa}$   
 $H_{\text{dark}} = 2.8 \pm 0.2 \text{ GPa}$

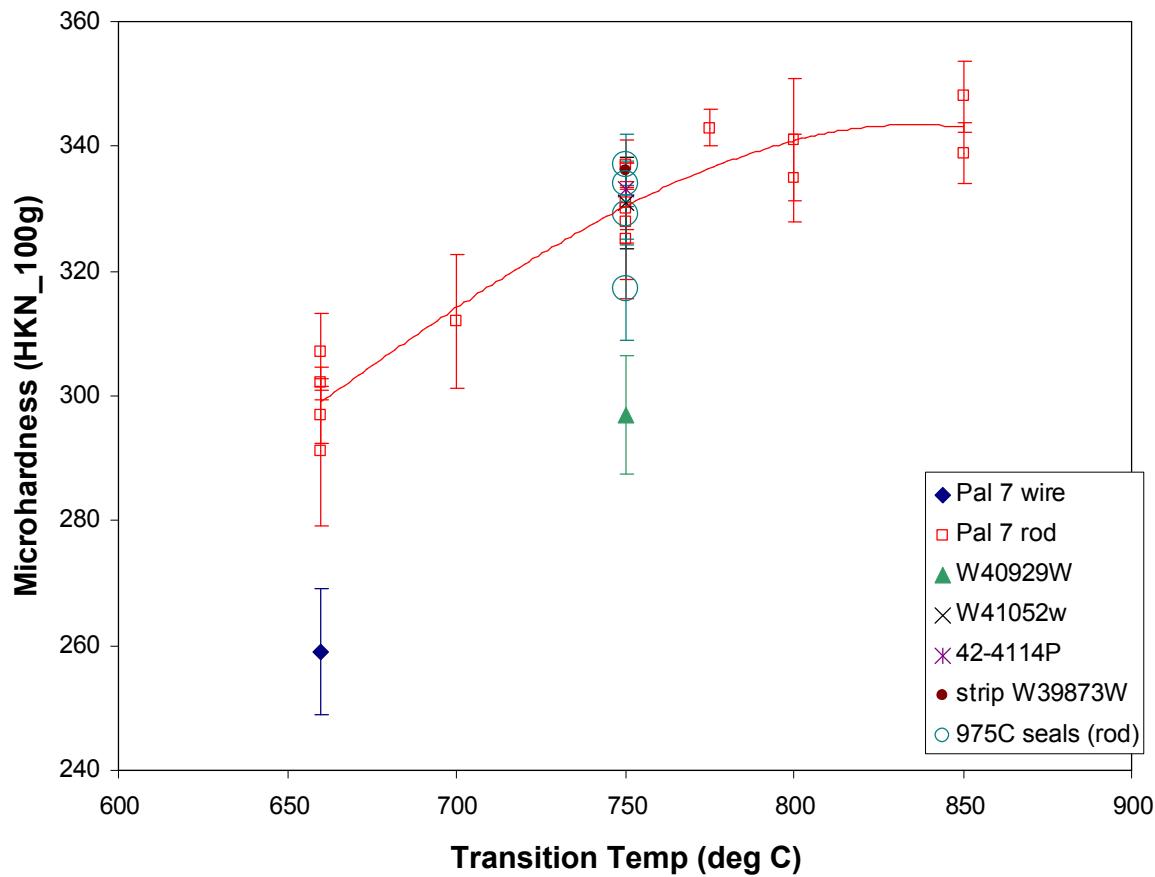
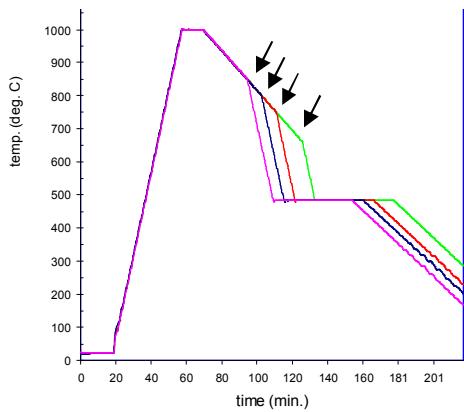
Bulk H (ASTM B540)=  $3.2\text{-}3.9 \text{ GPa}$

## 3<sup>rd</sup> (and final) attempt to understand and improve Pal-7 hardness: Cooling-Rate “Transition” Study

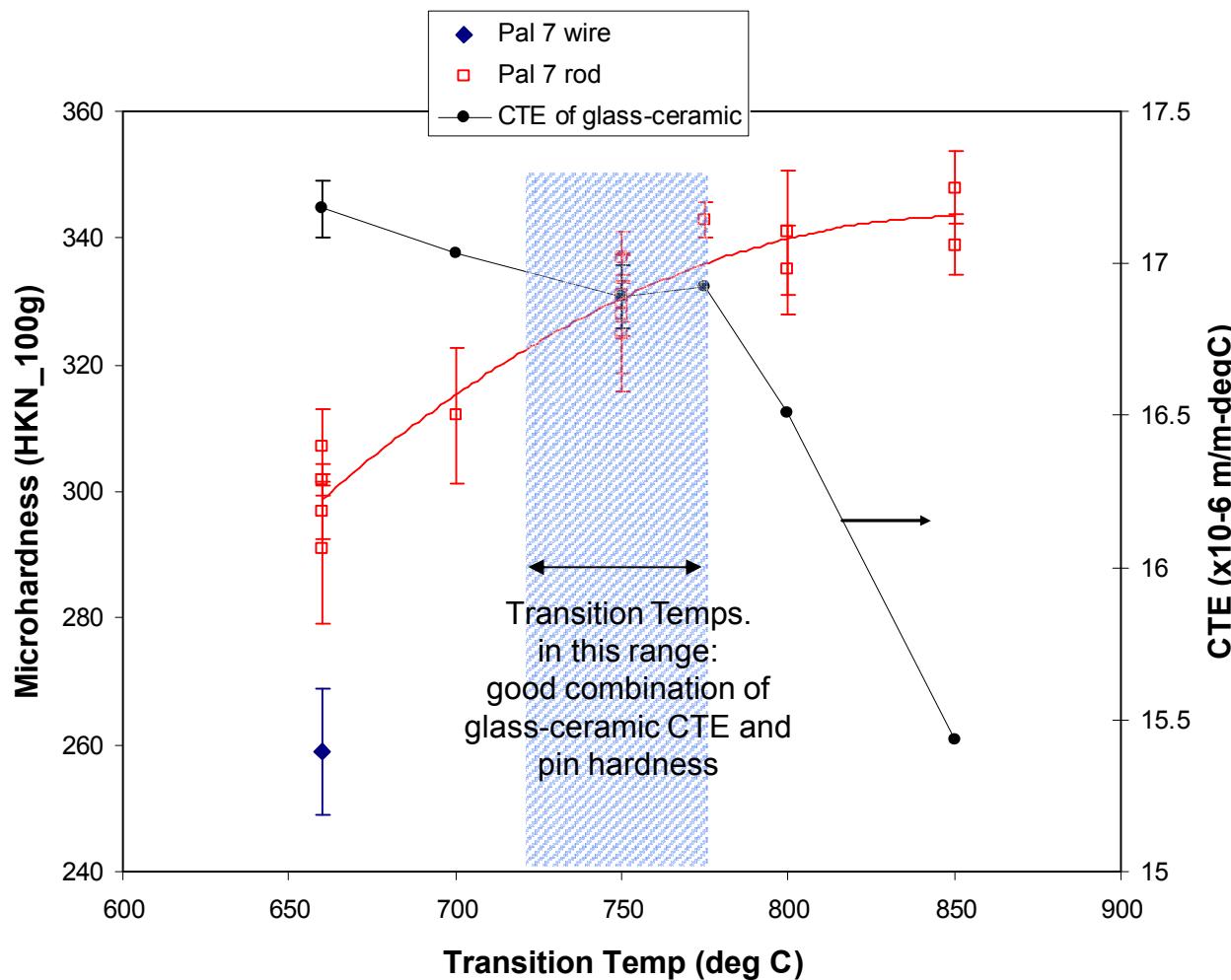


- Cool at a slow rate initially to achieve the correct CTE of the glass-ceramic
- Transition to a faster cooling rate to promote pin hardening, analyze the effect of this transition temp. on pin hardness.
- Goal: Limit the amount of time spent in the critical Pal-7 precipitation region to achieve *both the desired CTE of the glass-ceramic and high Paliney-7 pin hardness.*

# Positive Results: Consistent Trend of Increasing Pin Hardness with Increasing “Cooling Rate Transition Temp.”



## Combine with Glass-Ceramic CTE Data: A Processing Window has been developed for both Glass-Ceramic CTE and Pin Hardness



Superimposed CTE and Pin Hardness Results



# What causes low hardness values?

## Discontinuous Precipitation (DP)

### (or discontinuous coarsening (DC))

- Precipitation of a 2-phase lamellar structure behind a moving grain boundary
- Coarse precipitate structure is generally detrimental to mechanical properties

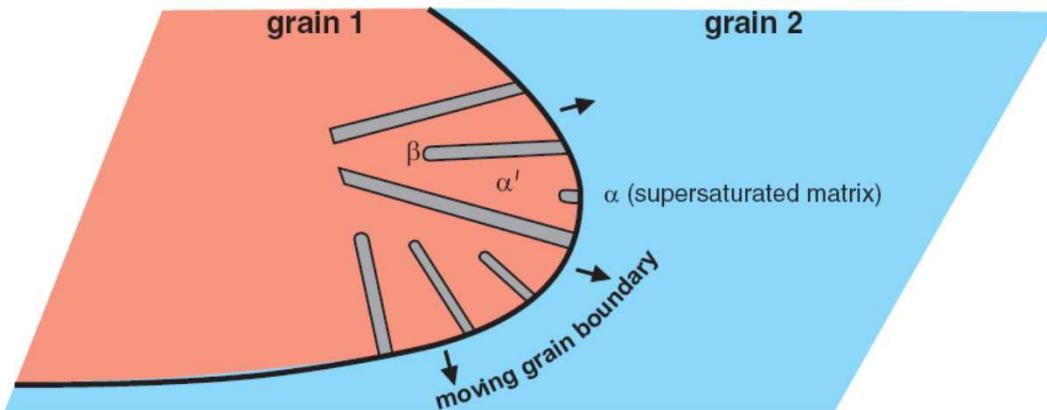
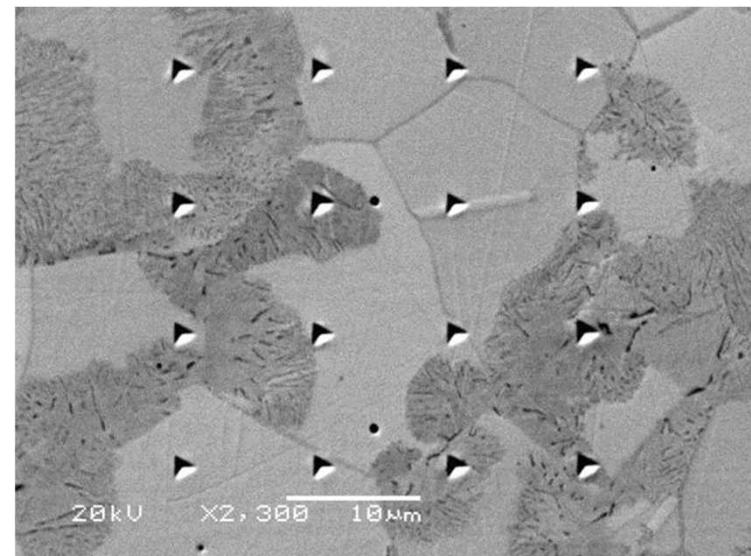
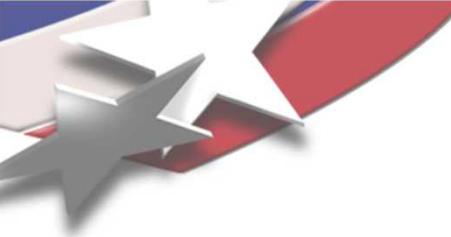
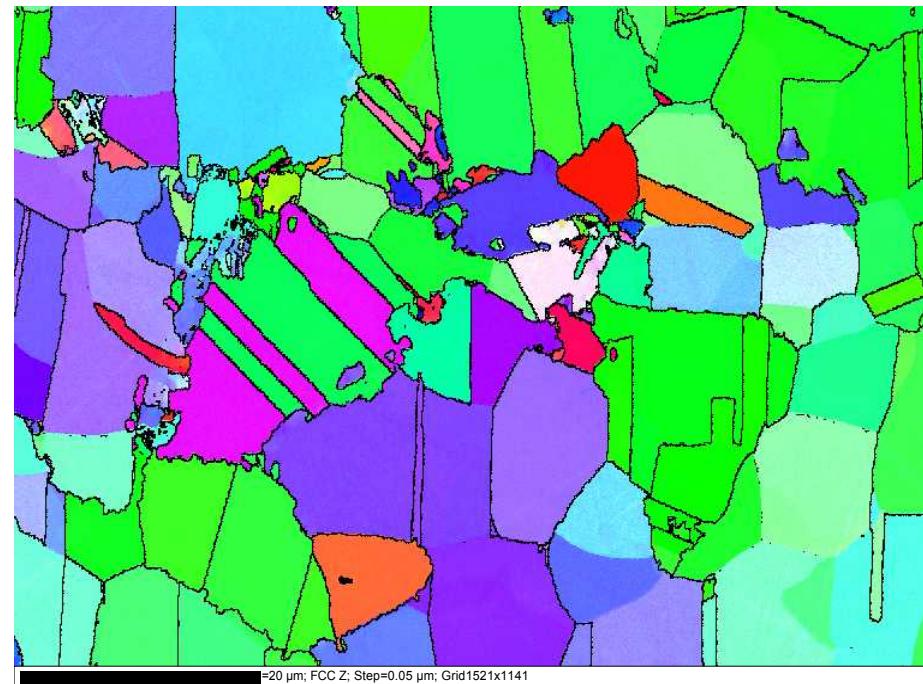
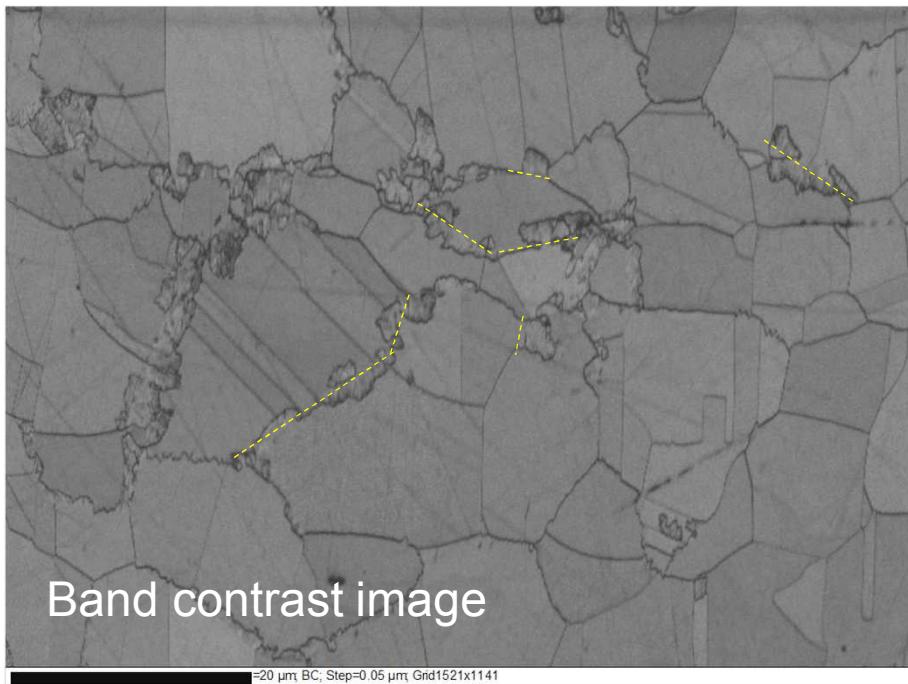


Fig. 1 Schematic of discontinuous precipitation,  $\alpha \rightarrow \alpha' + \beta$





# EBSD Characterization of Discontinuous Precipitation



EBSD shows that, in many regions, the fcc matrix of the lamellar two-phase structure has the same crystallographic orientation as the grain from which the reaction boundary had migrated. This is an essential characteristic of the discontinuous reaction.



# Summary

- Low hardness in Pal-7 was found to be due to discontinuous precipitation during the G-C/metal sealing process.
- Some heats of Pal-7 are more susceptible to DP and show lower hardness after G-C seal cycle. Reasons for heat-to-heat differences are unknown.
- Bottom Line: A processing window was found which gives both acceptable Pal-7 pin hardness *and* the correct glass-ceramic CTE. The important aspect is to change to a fast cooling rate as early as possible, thereby limiting the time in the detrimental DP temperature range.

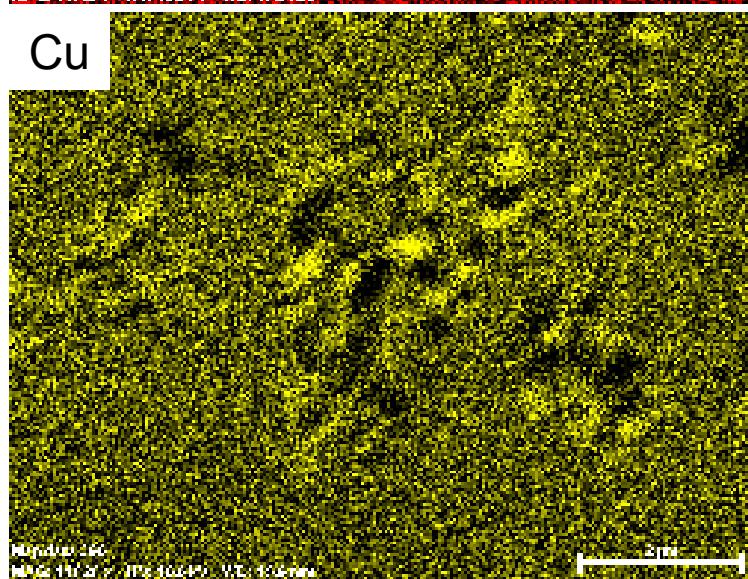
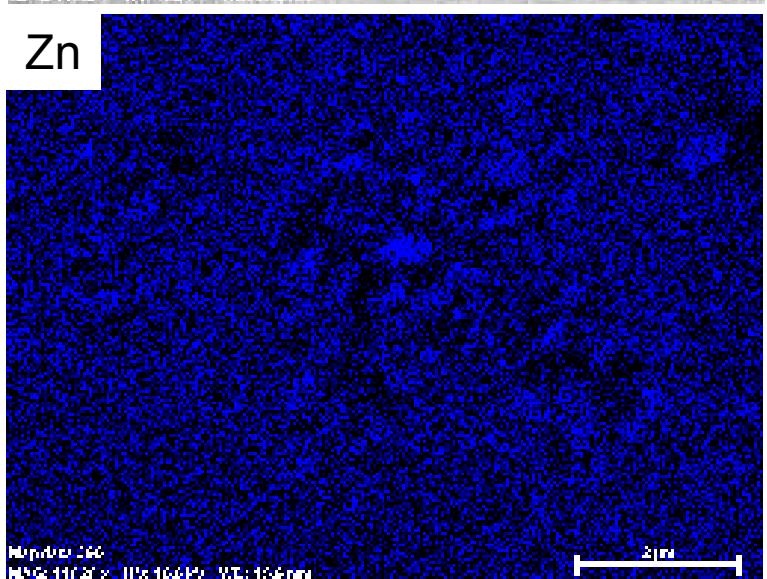
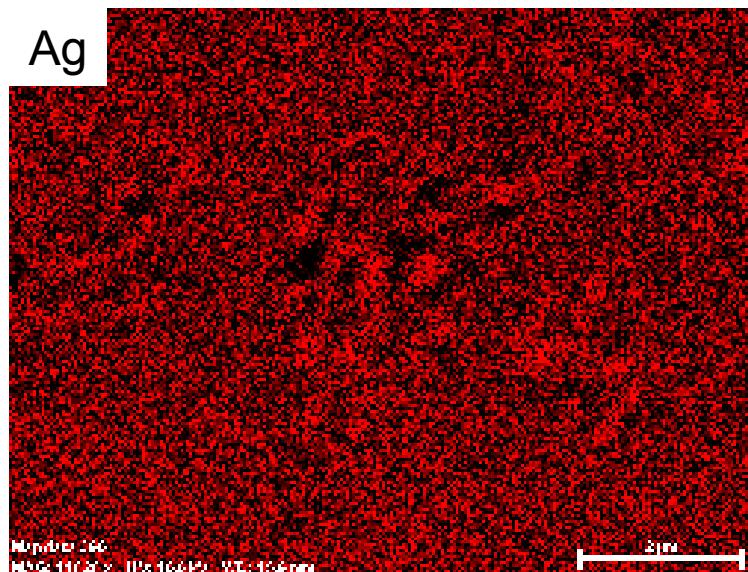
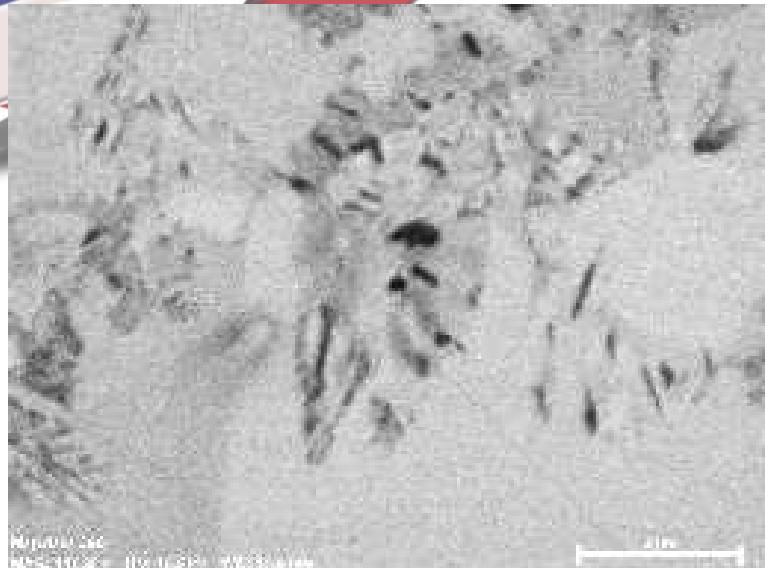
## Future Work

- Understand the metallurgy of Paliney-7 precipitation process. The results appear to support the DP range around 700-725°C. If you slow-cool below this temp, there will be significant “discontinuous”/coarse precipitation and lower hardness.
- What is the precipitate phase in DC? Is it different than the normal strengthening ppt.?
- What is the trade-off among precipitate vol. %, matrix grain size, and 2-phase region hardness (lamellar spacing)?



## Acknowledgements

**Thanks to Tom Buchheit and Jeff Rodelas (Missouri Tech. University) for nano-indentation hardness testing and Alice Kilgo and Debbie LaPierre for Knoop microhardness and metallography. Thanks also to Joe Michael and Bonnie McKenzie for SEM characterization work. Deringer-Ney Inc. is acknowledged for providing samples from the various heats of Paliney-7.**



EDS maps.

Possibly higher Ag, Cu, and Zn in the dark precipitates. Difficult to tell conclusively.  
TEM samples needed.